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TS5A23157 Dual 10-Ω SPDT Analog Switch

1 Features

- Low ON-State Resistance (15 Ω at 125°C)
- 125°C Operation
- Control Inputs are 5-V Tolerant
- Specified Break-Before-Make Switching
- Low Charge Injection
- Excellent ON-Resistance Matching
- Low Total Harmonic Distortion
- 1.8-V to 5.5-V Single-Supply Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)

2 Applications

- Sample-and-Hold Circuits
- Battery-Powered Equipment
- Audio and Video Signal Routing
- Communication Circuits

3 Description

The TS5A23157 device is a dual single-pole double-throw (SPDT) analog switch designed to operate from 1.65 V to 5.5 V. This device can handle both digital and analog signals. Signals up to 5.5 V (peak) can be transmitted in either direction.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TS5A23157DGS	VSSOP (10)	3.00 mm × 3.00 mm
TS5A23157RSE	UQFN (10)	2.00 mm × 1.50 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Block Diagram

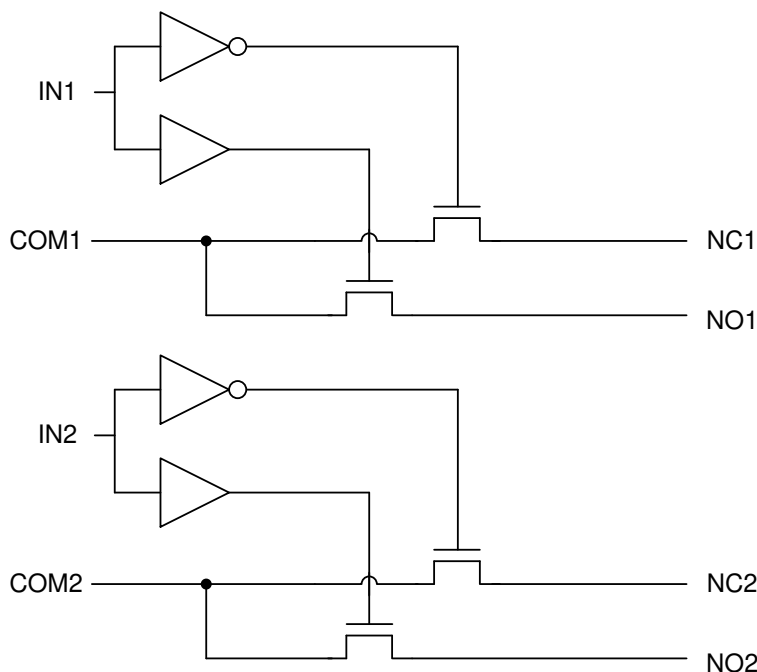


Table of Contents

1 Features	1	8.2 Functional Block Diagram	16
2 Applications	1	8.3 Feature Description	16
3 Description	1	8.4 Device Functional Modes	16
4 Revision History	2	9 Application and Implementation	17
5 Pin Configuration and Functions	3	9.1 Application Information	17
6 Specifications	4	9.2 Typical Application	17
6.1 Absolute Maximum Ratings	4	10 Power Supply Recommendations	18
6.2 ESD Ratings	4	11 Layout	19
6.3 Recommended Operating Conditions	4	11.1 Layout Guidelines	19
6.4 Thermal Information	4	11.2 Layout Example	19
6.5 Electrical Characteristics for 5-V Supply	5	12 Device and Documentation Support	20
6.6 Electrical Characteristics for 3.3-V Supply	7	12.1 Device Support	20
6.7 Electrical Characteristics for 2.5-V Supply	8	12.2 Documentation Support	21
6.8 Electrical Characteristics for 1.8-V Supply	9	12.3 Community Resources	21
6.9 Typical Characteristics	10	12.4 Trademarks	21
7 Parameter Measurement Information	12	12.5 Electrostatic Discharge Caution	21
8 Detailed Description	16	12.6 Glossary	21
8.1 Overview	16	13 Mechanical, Packaging, and Orderable Information	21

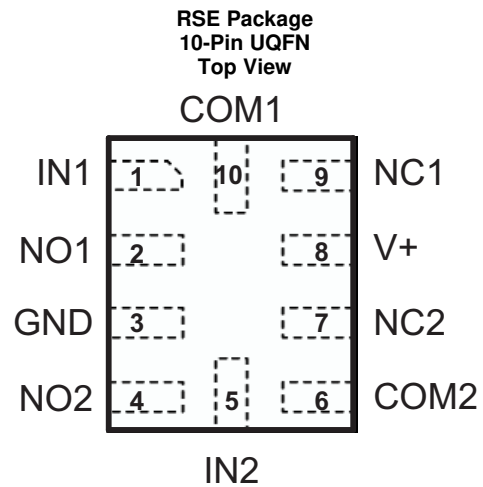
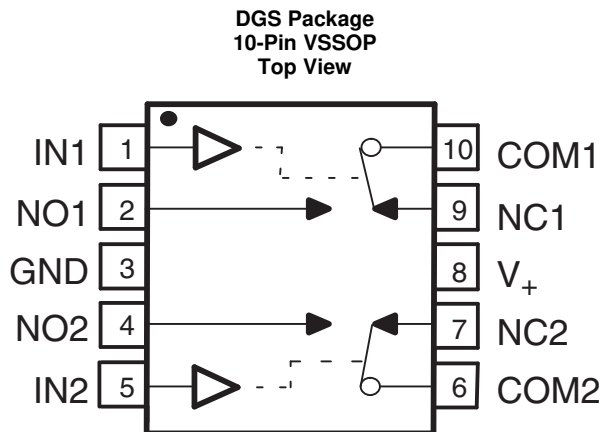
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision E (June 2015) to Revision F	Page
• Changed <i>Feature</i> From: Low ON-State Resistance (10 Ω) To: Low ON-State Resistance (15 Ω at 125°C)	1
• Added <i>Feature</i> : 125°C Operation	1
• Added Junction Temperature To the <i>Absolute Maximum Ratings</i> table	4
• Changed the Operating temperature MAX value From: 85°C To: 125°C in the <i>Recommended Operating Conditions</i> table	4
• Changed the <i>Thermal Information</i> table	4
• Changed r_{on} in the <i>Electrical Characteristics for 5-V Supply</i> table	5
• Changed V_{IH} in the <i>Electrical Characteristics for 5-V Supply</i> table	5
• Changed t_{ON} and t_{OFF} in the <i>Electrical Characteristics for 5-V Supply</i> table	5
• Changed r_{on} in the <i>Electrical Characteristics for 3.3-V Supply</i> table	7
• Changed t_{ON} and t_{OFF} in the <i>Electrical Characteristics for 3.3-V Supply</i> table	7
• Changed r_{on} in the <i>Electrical Characteristics for 2.5-V Supply</i> table	8
• Changed t_{ON} and t_{OFF} in the <i>Electrical Characteristics for 2.5-V Supply</i> table	8
• Changed r_{on} in the <i>Electrical Characteristics for 1.8-V Supply</i> table	9
• Changed t_{ON} and t_{OFF} in the <i>Electrical Characteristics for 1.8-V Supply</i> table	9

Changes from Revision D (October 2013) to Revision E	Page
• Added <i>Pin Configuration and Functions</i> section, <i>ESD Ratings</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section	1

5 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1	IN1	I	Select pin for switch 1
2	NO1	I/O	Normally open I/O for switch 1
3	GND	—	Ground
4	NO2	I/O	Normally open I/O for switch 2
5	IN2	I	Select pin for switch 2
6	COM2	I/O	Common I/O for switch 2
7	NC2	I/O	Normally closed I/O for switch 2
8	V+	—	Power supply pin
9	NC1	I/O	Normally closed I/O for switch 1
10	COM1	I/O	Common I/O for switch 1

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V ₊	Supply voltage ⁽²⁾		−0.5	6.5	V
V _{NC} V _{NO} V _{COM}	Analog voltage ⁽²⁾⁽³⁾⁽⁴⁾		−0.5	V ₊ + 0.5	V
I _{I/OK}	Analog port diode current	V _{NC} , V _{NO} , V _{COM} < 0 or V _{NC} , V _{NO} , V _{COM} > V ₊	±50		mA
I _{NC} I _{NO} I _{COM}	On-state switch current	V _{NC} , V _{NO} , V _{COM} = 0 to V ₊	±50		mA
V _{IN}	Digital input voltage ⁽²⁾⁽³⁾		−0.5	6.5	V
I _{IK}	Digital input clamp current	V _{IN} < 0	−50		mA
	Continuous current through V ₊ or GND		±100		mA
T _J	Junction Temperature		150		°C
T _{stg}	Storage temperature		−65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (4) This value is limited to 5.5 V maximum.

6.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V _{I/O}	Switch input/output voltage	0	V ₊	V
V ₊	Supply voltage	1.65	5.5	V
V _I	Control input voltage	0	5.5	V
T _A	Operating temperature	−40	125	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TS5A23157		UNIT
		DGS (VSSOP)	RSE (UQFN)	
		10 PINS	10 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	210.5	215.4	°C/W
R _{θJCTop}	Junction-to-case (top) thermal resistance	99.1	140.2	°C/W
R _{θJB}	Junction-to-board thermal resistance	132.4	137.9	°C/W
ψ _{JT}	Junction-to-top characterization parameter	29.1	13.7	°C/W
ψ _{JB}	Junction-to-board characterization parameter	130.5	137.6	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics for 5-V Supply

 $V_+ = 4.5 \text{ V to } 5.5 \text{ V}$, $T_A = -40^\circ\text{C to } 85^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A	V_+	MIN	TYP ⁽¹⁾	MAX	UNIT
ANALOG SWITCH							
V_{COM} , V_{NO} , V_{NC} Analog signal range				0		V_+	V
r_{on} ON-state resistance	$0 \leq V_{NO} \text{ or } V_{NC} \leq V_+$, $I_{COM} = -30 \text{ mA}$, Switch ON, see Figure 9	Full -40 to 125°C	4.5 V			10 15	Ω
Δr_{on} ON-state resistance match between channels	$V_{NO} \text{ or } V_{NC} = 3.15 \text{ V}$, $I_{COM} = -30 \text{ mA}$, Switch ON, see Figure 9	25°C	4.5 V		0.15		Ω
$r_{on(flat)}$ ON-state resistance flatness	$0 \leq V_{NO} \text{ or } V_{NC} \leq V_+$, $I_{COM} = -30 \text{ mA}$, Switch ON, see Figure 9	25°C	4.5 V		4		Ω
$I_{NC(OFF)}$, $I_{NO(OFF)}$ NC, NO OFF leakage current	$V_{NC} \text{ or } V_{NO} = 0 \text{ to } V_+$, $V_{COM} = 0 \text{ to } V_+$, Switch OFF, see Figure 10	25°C Full	5.5 V	-1	0.05	1	μA
$I_{NC(ON)}$, $I_{NO(ON)}$ NC, NO ON leakage current	$V_{NC} \text{ or } V_{NO} = 0 \text{ to } V_+$, $V_{COM} = \text{Open}$, Switch ON, see Figure 10	25°C Full	5.5 V	-0.1		0.1	μA
$I_{COM(ON)}$ COM ON leakage current	$V_{NC} \text{ or } V_{NO} = \text{Open}$, $V_{COM} = 0 \text{ to } V_+$, Switch ON, see Figure 10	25°C Full	5.5 V	-0.1		0.1	μA
DIGITAL INPUTS (IN12, IN2)⁽²⁾							
V_{IH} Input logic high		Full -40 to 125°C	4.75 V to 5.25 V	$V_+ \times 0.7$ 3.1			V
V_{IL} Input logic low		Full		$V_+ \times 0.3$			V
I_{IH} , I_{IL} Input leakage current	$V_{IN} = 5.5 \text{ V or } 0$	25°C Full	5.5 V	-1	0.05	1	μA
DYNAMIC							
t_{ON} Turnon time	$V_{NC} = \text{GND and } V_{NO} = V_+$, or $V_{NC} = V_+ \text{ and } V_{NO} = \text{GND}$, $R_L = 500 \Omega$, $C_L = 50 \text{ pF}$, see Figure 12	Full -40 to 125°C	4.5 V to 5.5 V 4.75 V to 5.25 V	1.7 1.2		5.7 8.7	ns
t_{OFF} Turnoff time	$V_{NC} = \text{GND and } V_{NO} = V_+$, or $V_{NC} = V_+ \text{ and } V_{NO} = \text{GND}$, $R_L = 500 \Omega$, $C_L = 50 \text{ pF}$, see Figure 12	Full -40 to 125°C	4.5 V to 5.5 V 4.75 V to 5.25 V	0.8 0.5		3.8 6.8	ns
t_{BBM} Break-before-make time	$V_{NC} = V_{NO} = V_+/2$, $R_L = 50 \Omega$, $C_L = 35 \text{ pF}$, see Figure 13	Full	4.5 V to 5.5 V	0.5			ns
Q_C Charge injection	$V_{NC} = V_{NO} = V_+/2$, $R_L = 50 \Omega$, See Figure 17	25°C	5 V		7		pC
$C_{NC(OFF)}$, $C_{NO(OFF)}$ NC, NO OFF capacitance	$V_{NC} \text{ or } V_{NO} = V_+ \text{ or GND}$, Switch OFF, see Figure 11	25°C	5 V		5.5		pF
$C_{NC(ON)}$, $C_{NO(ON)}$ NC, NO ON capacitance	$V_{NC} \text{ or } V_{NO} = V_+ \text{ or GND}$, Switch ON, see Figure 11	25°C	5 V		17.5		pF
$C_{COM(ON)}$ COM ON capacitance	$V_{COM} = V_+ \text{ or GND}$, Switch ON, see Figure 11	25°C	5 V		17.5		pF
C_{IN} Digital input capacitance	$V_{IN} = V_+ \text{ or GND}$, See Figure 11	25°C	5 V		2.8		pF
BW Bandwidth	$R_L = 50 \Omega$, Switch ON, see Figure 14	25°C	4.5 V		220		MHz

(1) $T_A = 25^\circ\text{C}$.

(2) All unused digital inputs of the device must be held at V_+ or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, [SCBA004](#).

Electrical Characteristics for 5-V Supply (continued)

 $V_+ = 4.5\text{ V to }5.5\text{ V}$, $T_A = -40^\circ\text{C to }85^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A	V_+	MIN	TYP ⁽¹⁾	MAX	UNIT
O_{ISO}	OFF isolation	$R_L = 50\ \Omega$, $f = 10\text{ MHz}$,	Switch OFF, see Figure 15	25°C	4.5 V		–65		dB
X_{TALK}	Crosstalk	$R_L = 50\ \Omega$, $f = 10\text{ MHz}$,	Switch ON, see Figure 16	25°C	4.5 V		–66		dB
THD	Total harmonic distortion	$R_L = 600\ \Omega$, $C_L = 50\text{ pF}$,	$f = 600\text{ Hz to }20\text{ kHz}$, see Figure 18	25°C	4.5 V		0.01%		
SUPPLY									
I_+	Positive supply current	$V_{IN} = V_+$ or GND,	Switch ON or OFF	25°C	5.5 V			1	μA
				Full				10	
ΔI_+	Change in supply current	$V_{IN} = V_+ - 0.6\text{ V}$		Full	5.5 V			500	μA

6.6 Electrical Characteristics for 3.3-V Supply

 $V_+ = 3\text{ V to }3.6\text{ V}$, $T_A = -40^\circ\text{C to }85^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A	V_+	MIN	TYP ⁽¹⁾	MAX	UNIT
ANALOG SWITCH							
V_{COM} , V_{NO} , V_{NC} Analog signal range				0		V_+	V
r_{on} ON-state resistance	$0 \leq V_{NO} \text{ or } V_{NC} \leq V_+$, $I_{COM} = -24\text{ mA}$, Switch ON, see Figure 9	Full -40 to 125°C	3 V			18 23	Ω
Δr_{on} ON-state resistance match between channels	$V_{NO} \text{ or } V_{NC} = 2.1\text{ V}$, $I_{COM} = -24\text{ mA}$, Switch ON, see Figure 9	25°C	3 V		0.2		Ω
$r_{on(Flat)}$ ON-state resistance flatness	$0 \leq V_{NO} \text{ or } V_{NC} \leq V_+$, $I_{COM} = -24\text{ mA}$, Switch ON, see Figure 11	25°C	3 V		9		Ω
$I_{NC(OFF)}$, $I_{NO(OFF)}$ NC, NO OFF leakage current	$V_{NC} \text{ or } V_{NO} = 0 \text{ to } V_+$, $V_{COM} = 0 \text{ to } V_+$, Switch OFF, see Figure 10	25°C Full	3.6 V	-1	0.05	1	μA
$I_{NC(ON)}$, $I_{NO(ON)}$ NC, NO ON leakage current	$V_{NC} \text{ or } V_{NO} = 0 \text{ to } V_+$, $V_{COM} = \text{Open}$, Switch ON, see Figure 10	25°C Full	3.6 V	-0.1		0.1	μA
$I_{COM(ON)}$ COM ON leakage current	$V_{NC} \text{ or } V_{NO} = \text{Open}$, $V_{COM} = 0 \text{ to } V_+$, Switch ON, see Figure 10	25°C Full	3.6 V	-0.1		0.1	μA
DIGITAL INPUTS (IN12, IN2)⁽²⁾							
V_{IH} Input logic high		Full		$V_+ \times 0.7$			V
V_{IL} Input logic low		Full				$V_+ \times 0.3$	V
I_{IH} , I_{IL} Input leakage current	$V_{IN} = 5.5\text{ V or }0$	25°C Full	3.6 V	-1	0.05	1	μA
DYNAMIC							
t_{ON} Turn-on time	$V_{NC} = \text{GND and } V_{NO} = V_+$ or $V_{NC} = V_+ \text{ and } V_{NO} = \text{GND}$, $R_L = 500\ \Omega$, $C_L = 50\text{ pF}$, see Figure 12	Full -40 to 125°C	3 V to 3.6 V	2.5		7.6	ns
t_{OFF} Turnoff time	$V_{NC} = \text{GND and } V_{NO} = V_+$ or $V_{NC} = V_+ \text{ and } V_{NO} = \text{GND}$, $R_L = 500\ \Omega$, $C_L = 50\text{ pF}$, see Figure 12	Full -40 to 125°C	3 V to 3.6 V	1.5		5.3	ns
t_{BBM} Break-before-make time	$V_{NC} = V_{NO} = V_+/2$, $R_L = 50\ \Omega$, $C_L = 35\text{ pF}$, see Figure 13	Full	3 V to 3.6 V	0.5			ns
Q_C Charge injection	$R_L = 50\ \Omega$, $C_L = 0.1\text{ nF}$, see Figure 17	25°C	3.3 V		3		pC
BW Bandwidth	$R_L = 50\ \Omega$, Switch ON, see Figure 14	25°C	3 V		220		MHz
O_{ISO} OFF isolation	$R_L = 50\ \Omega$, $f = 10\text{ MHz}$, Switch OFF, see Figure 15	25°C	3 V		-65		dB
X_{TALK} Crosstalk	$R_L = 50\ \Omega$, $f = 10\text{ MHz}$, Switch ON, see Figure 16	25°C	3 V		-66		dB
THD Total harmonic distortion	$R_L = 600\ \Omega$, $C_L = 50\text{ pF}$, $f = 600\text{ Hz to }20\text{ kHz}$, see Figure 18	25°C	3 V		0.015%		
SUPPLY							
I_+ Positive supply current	$V_{IN} = V_+ \text{ or GND}$, Switch ON or OFF	25°C Full	3.6 V			1 10	μA
ΔI_+ Change in supply current	$V_{IN} = V_+ - 0.6\text{ V}$	Full	3.6 V			500	μA

(1) $T_A = 25^\circ\text{C}$.

(2) All unused digital inputs of the device must be held at V_+ or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, [SCBA004](#).

6.7 Electrical Characteristics for 2.5-V Supply

 $V_+ = 2.3 \text{ V to } 2.7 \text{ V}$, $T_A = -40^\circ\text{C to } 85^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A	V_+	MIN	TYP ⁽¹⁾	MAX	UNIT
ANALOG SWITCH							
$V_{\text{COM}}, V_{\text{NO}}, V_{\text{NC}}$ Analog signal range				0		V_+	V
r_{on} ON-state resistance	$0 \leq V_{\text{NO}} \text{ or } V_{\text{NC}} \leq V_+$, $I_{\text{COM}} = -8 \text{ mA}$, Switch ON, see Figure 9	Full -40 to 125°C	2.3 V			45 50	Ω
Δr_{on} ON-state resistance match between channels	$V_{\text{NO}} \text{ or } V_{\text{NC}} = 1.6 \text{ V}$, $I_{\text{COM}} = -8 \text{ mA}$, Switch ON, see Figure 9	25°C	2.3 V		0.5		Ω
$r_{\text{on(Flat)}}$ ON-state resistance flatness	$0 \leq V_{\text{NO}} \text{ or } V_{\text{NC}} \leq V_+$, $I_{\text{COM}} = -8 \text{ mA}$, Switch ON, see Figure 9	25°C	2.3 V		27		Ω
$I_{\text{NC(OFF)}}$, $I_{\text{NO(OFF)}}$ NC, NO OFF leakage current	$V_{\text{NC}} \text{ or } V_{\text{NO}} = 0 \text{ to } V_+$, $V_{\text{COM}} = 0 \text{ to } V_+$, Switch OFF, see Figure 10	25°C Full	2.7 V	-1	0.05	1	μA
$I_{\text{NC(ON)}}$, $I_{\text{NO(ON)}}$ NC, NO ON leakage current	$V_{\text{NC}} \text{ or } V_{\text{NO}} = 0 \text{ to } V_+$, $V_{\text{COM}} = \text{Open}$, Switch ON, see Figure 10	25°C Full	2.7 V	-0.1		0.1	μA
$I_{\text{COM(ON)}}$ COM ON leakage current	$V_{\text{NC}} \text{ or } V_{\text{NO}} = \text{Open}$, $V_{\text{COM}} = 0 \text{ to } V_+$, Switch ON, see Figure 10	25°C Full	2.7 V	-0.1		0.1	μA
DIGITAL INPUTS (IN12, IN2)⁽²⁾							
V_{IH} Input logic high		Full		$V_+ \times 0.7$			V
V_{IL} Input logic low		Full				$V_+ \times 0.3$	V
$I_{\text{IH}}, I_{\text{IL}}$ Input leakage current	$V_{\text{IN}} = 5.5 \text{ V or } 0$	25°C Full	2.7 V	-1	0.05	1	μA
DYNAMIC							
t_{ON} Turnon time	$V_{\text{NC}} = \text{GND and } V_{\text{NO}} = V_+$ or $V_{\text{NC}} = V_+ \text{ and } V_{\text{NO}} = \text{GND}$, $R_L = 500 \Omega$, $C_L = 50 \text{ pF}$, see Figure 12	Full -40 to 125°C	2.3 V to 2.7 V	3.5		14	ns
t_{OFF} Turnoff time	$V_{\text{NC}} = \text{GND and } V_{\text{NO}} = V_+$ or $V_{\text{NC}} = V_+ \text{ and } V_{\text{NO}} = \text{GND}$, $R_L = 500 \Omega$, $C_L = 50 \text{ pF}$, see Figure 12	Full -40 to 125°C	2.3 V to 2.7 V	2		7.5	ns
t_{BBM} Break-before-make time	$V_{\text{NC}} = V_{\text{NO}} = V_+/2$, $R_L = 50 \Omega$, $C_L = 35 \text{ pF}$, see Figure 13	Full	2.3 V to 2.7 V	0.5			ns
BW Bandwidth	$R_L = 50 \Omega$, Switch ON, see Figure 14	25°C	2.3 V		220		MHz
O_{ISO} OFF isolation	$R_L = 50 \Omega$, $f = 10 \text{ MHz}$, Switch OFF, see Figure 15	25°C	2.3 V		-65		dB
X_{TALK} Crosstalk	$R_L = 50 \Omega$, $f = 10 \text{ MHz}$, Switch ON, see Figure 16	25°C	2.3 V		-66		dB
THD Total harmonic distortion	$R_L = 600 \Omega$, $C_L = 50 \text{ pF}$, $f = 600 \text{ Hz to } 20 \text{ kHz}$, see Figure 18	25°C	2.3 V		0.025%		
SUPPLY							
I_+ Positive supply current	$V_{\text{IN}} = V_+ \text{ or GND}$, Switch ON or OFF	25°C Full	2.7 V			1 10	μA
ΔI_+ Change in supply current	$V_{\text{IN}} = V_+ - 0.6 \text{ V}$	Full	2.7 V			500	μA

(1) $T_A = 25^\circ\text{C}$.

(2) All unused digital inputs of the device must be held at V_+ or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, [SCBA004](#).

6.8 Electrical Characteristics for 1.8-V Supply

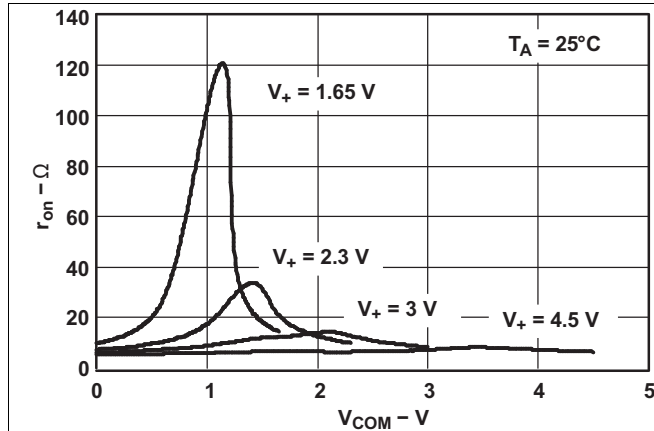
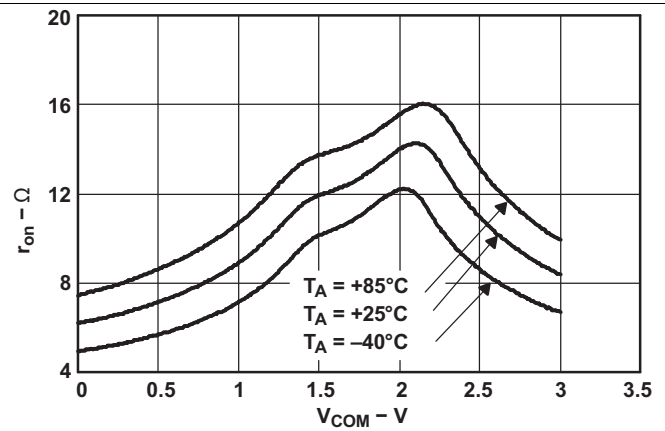
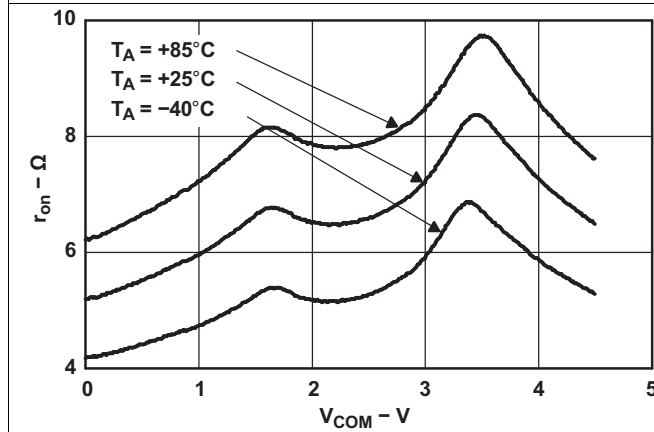
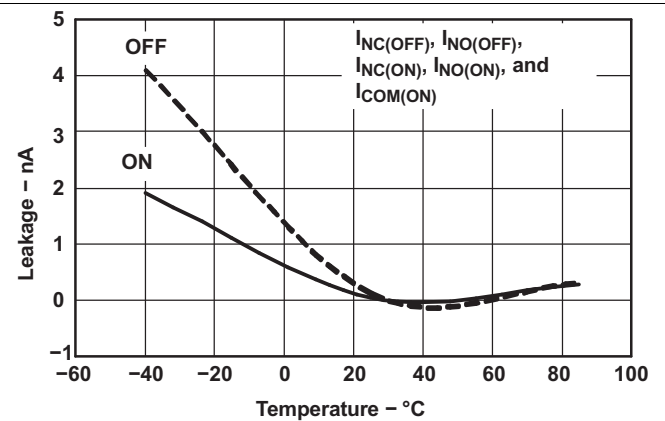
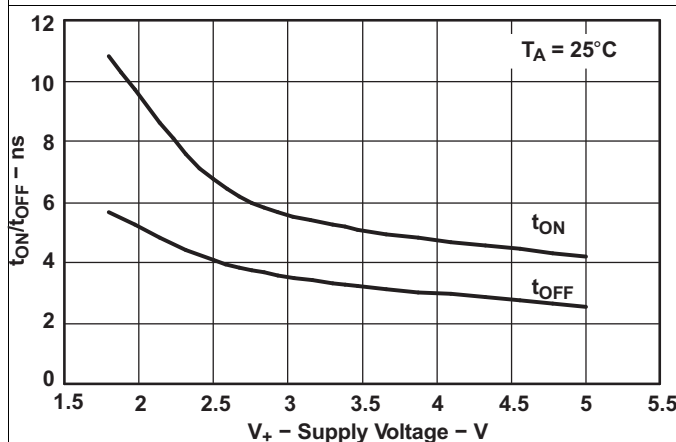
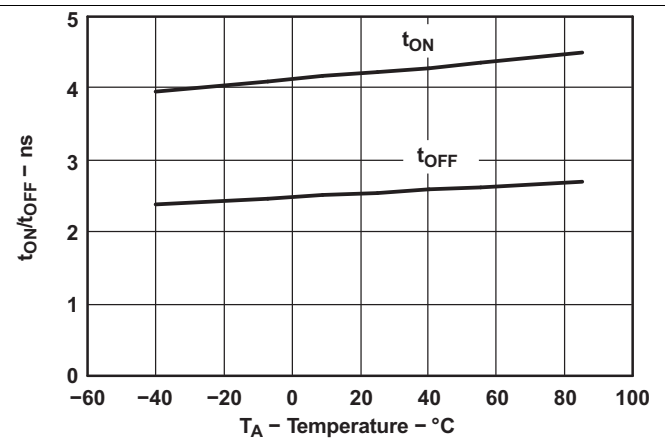
 $V_+ = 1.65 \text{ V to } 1.95 \text{ V}$, $T_A = -40^\circ\text{C to } 85^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T_A	V_+	MIN	TYP ⁽¹⁾	MAX	UNIT
ANALOG SWITCH							
V_{COM}, V_{NO}, V_{NC} Analog signal range				0		V_+	V
r_{on} ON-state resistance	$0 \leq V_{NO} \text{ or } V_{NC} \leq V_+$, $I_{COM} = -4 \text{ mA}$, Switch ON, see Figure 9	Full -40 to 125°C	1.65 V			140 180	Ω
Δr_{on} ON-state resistance match between channels	$V_{NO} \text{ or } V_{NC} = 1.15 \text{ V}$, $I_{COM} = -4 \text{ mA}$, Switch ON, see Figure 9	25°C	1.65 V		1		Ω
$r_{on(Flat)}$ ON-state resistance flatness	$0 \leq V_{NO} \text{ or } V_{NC} \leq V_+$, $I_{COM} = -4 \text{ mA}$, Switch ON, see Figure 9	25°C	1.65 V		110		Ω
$I_{NC(OFF)}, I_{NO(OFF)}$ NC, NO OFF leakage current	$V_{NC} \text{ or } V_{NO} = 0 \text{ to } V_+$, $V_{COM} = 0 \text{ to } V_+$, Switch OFF, see Figure 10	25°C Full	1.95 V	-1	0.05	1	μA
$I_{NC(ON)}, I_{NO(ON)}$ NC, NO ON leakage current	$V_{NC} \text{ or } V_{NO} = 0 \text{ to } V_+$, $V_{COM} = \text{Open}$, Switch ON, see Figure 10	25°C Full	1.95 V	-0.1		0.1	μA
$I_{COM(ON)}$ COM ON leakage current	$V_{NC} \text{ or } V_{NO} = \text{Open}$, $V_{COM} = 0 \text{ to } V_+$, Switch ON, see Figure 10	25°C Full	1.95 V	-0.1		0.1	μA
DIGITAL INPUTS (IN12, IN2)⁽²⁾							
V_{IH} Input logic high		Full		$V_+ \times 0.75$			V
V_{IL} Input logic low		Full				$V_+ \times 0.25$	V
I_{IH}, I_{IL} Input leakage current	$V_{IN} = 5.5 \text{ V or } 0$	25°C Full	1.95 V	-1	0.05	1	μA
DYNAMIC							
t_{ON} Turnon time	$V_{NC} = \text{GND and } V_{NO} = V_+$, or $V_{NC} = V_+ \text{ and } V_{NO} = \text{GND}$, $R_L = 500 \Omega$, $C_L = 50 \text{ pF}$, see Figure 12	Full -40 to 125°C	1.65 V to 1.95 V	7		24	ns
t_{OFF} Turnoff time	$V_{NC} = \text{GND and } V_{NO} = V_+$, or $V_{NC} = V_+ \text{ and } V_{NO} = \text{GND}$, $R_L = 500 \Omega$, $C_L = 50 \text{ pF}$, see Figure 12	Full -40 to 125°C	1.65 V to 1.95 V	3		13	ns
t_{BBM} Break-before-make time	$V_{NC} = V_{NO} = V_+/2$, $R_L = 50 \Omega$, $C_L = 35 \text{ pF}$, see Figure 13	Full	1.65 V to 1.95 V	0.5			ns
BW Bandwidth	$R_L = 50 \Omega$, Switch ON, see Figure 14	25°C	1.8 V		220		MHz
O_{ISO} OFF isolation	$R_L = 50 \Omega$, $f = 10 \text{ MHz}$, Switch OFF, see Figure 15	25°C	1.8 V		-60		dB
X_{TALK} Crosstalk	$R_L = 50 \Omega$, $f = 10 \text{ MHz}$, Switch ON, see Figure 16	25°C	1.8 V		-66		dB
THD Total harmonic distortion	$R_L = 600 \Omega$, $C_L = 50 \text{ pF}$, $f = 600 \text{ Hz to } 20 \text{ kHz}$, see Figure 18	25°C	1.8 V		0.015%		
SUPPLY							
I_+ Positive supply current	$V_{IN} = V_+ \text{ or GND}$, Switch ON or OFF	25°C Full	1.95 V			1 10	μA
ΔI_+ Change in supply current	$V_{IN} = V_+ - 0.6 \text{ V}$	Full	1.95 V			500	μA

(1) $T_A = 25^\circ\text{C}$.

(2) All unused digital inputs of the device must be held at V_+ or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, [SCBA004](#).

6.9 Typical Characteristics


Figure 1. r_{on} vs V_{COM}

Figure 2. r_{on} vs V_{COM} ($V_+ = 3$ V)

Figure 3. r_{on} vs V_{COM} ($V_+ = 5$ V)

Figure 4. Leakage Current vs Temperature ($V_+ = 5.5$ V)

Figure 5. t_{ON} and t_{OFF} vs V_+

Figure 6. t_{ON} and t_{OFF} vs Temperature ($V_+ = 5$ V)

Typical Characteristics (continued)

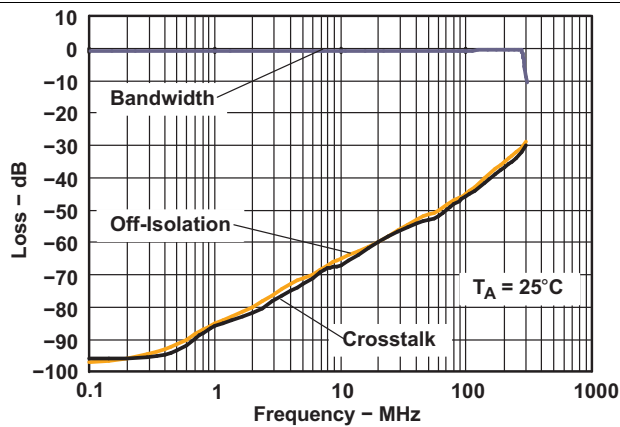


Figure 7. Frequency Response ($V_+ = 3\text{ V}$)

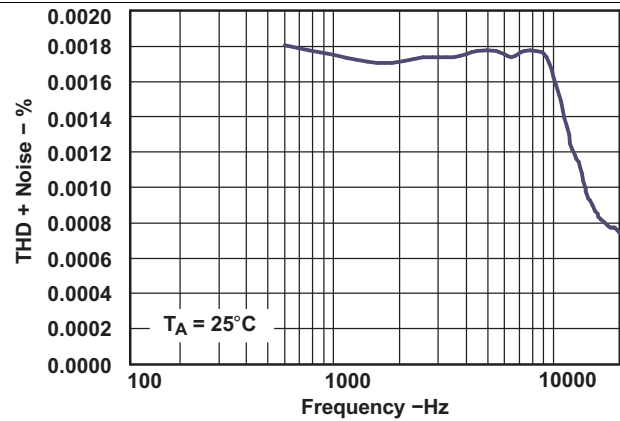


Figure 8. Total Harmonic Distortion (THD) vs Frequency ($V_+ = 3\text{ V}$)

7 Parameter Measurement Information

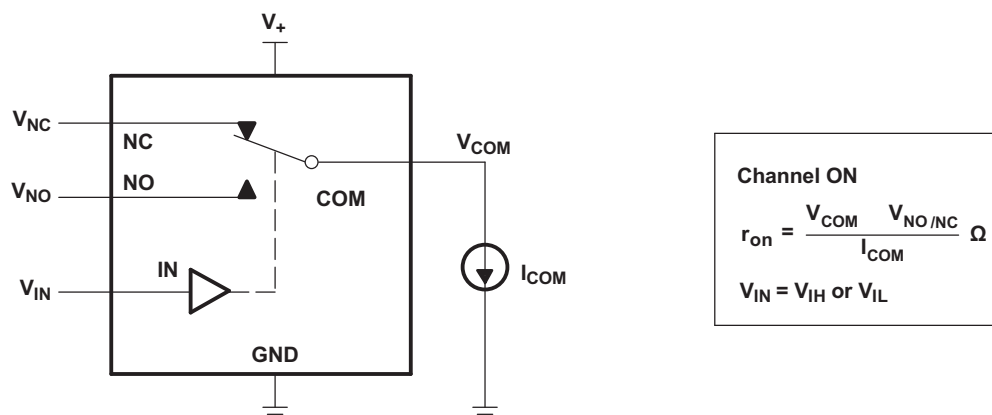


Figure 9. ON-State Resistance (r_{on})

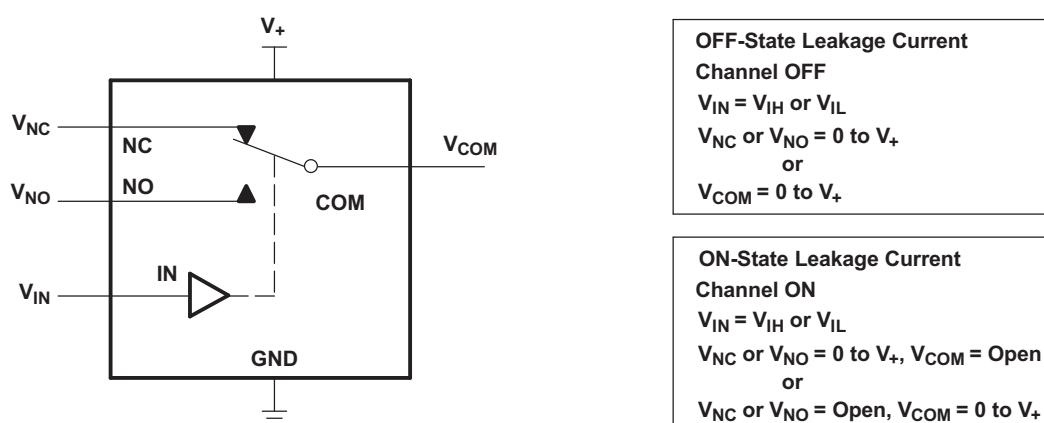


Figure 10. ON- and OFF-State Leakage Current ($I_{COM(ON)}$, $I_{NC(OFF)}$, $I_{NO(OFF)}$, $I_{NC(ON)}$, $I_{NO(ON)}$)

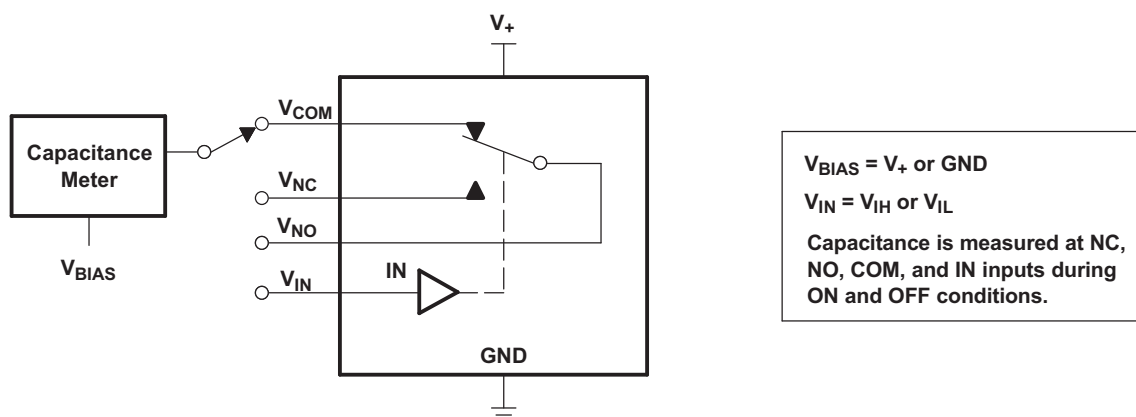


Figure 11. Capacitance (C_{IN} , $C_{COM(ON)}$, $C_{NC(OFF)}$, $C_{NO(OFF)}$, $C_{NC(ON)}$, $C_{NO(ON)}$)

Parameter Measurement Information (continued)

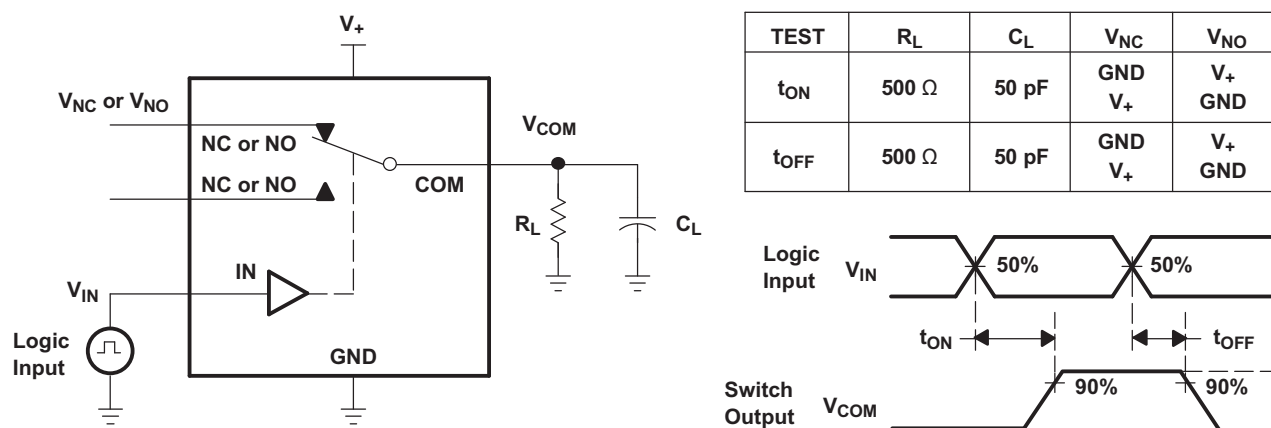


Figure 12. Turnon (t_{ON}) and Turnoff (t_{OFF}) Time

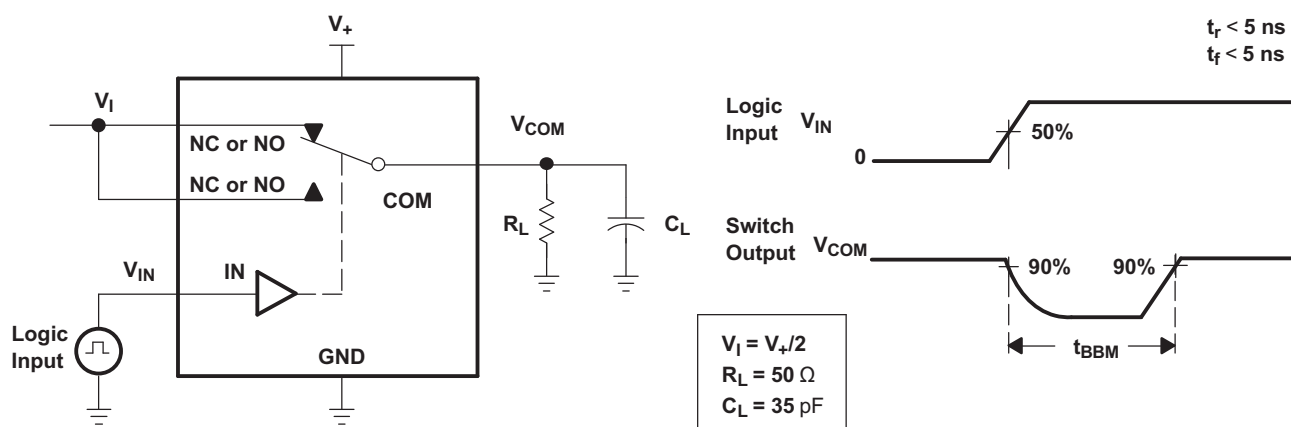


Figure 13. Break-Before-Make (t_{BBM}) Time

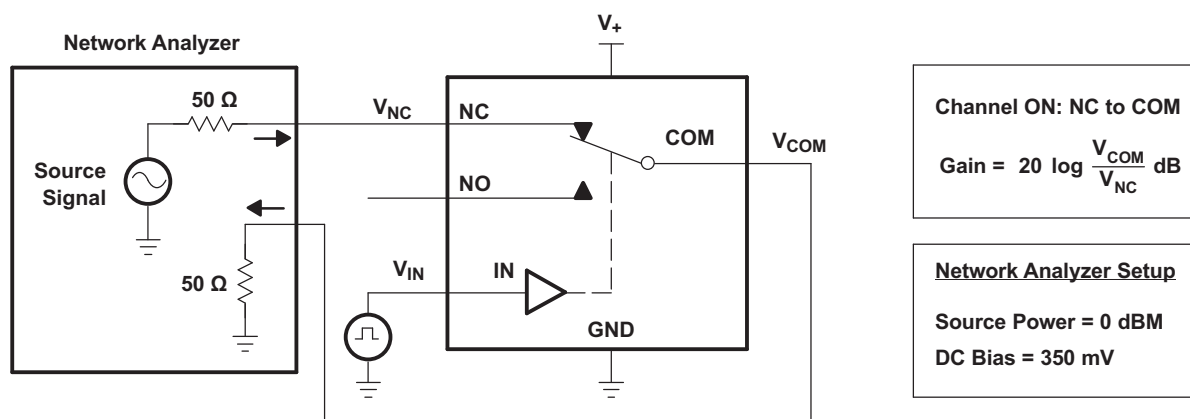


Figure 14. Frequency Response (BW)

Parameter Measurement Information (continued)

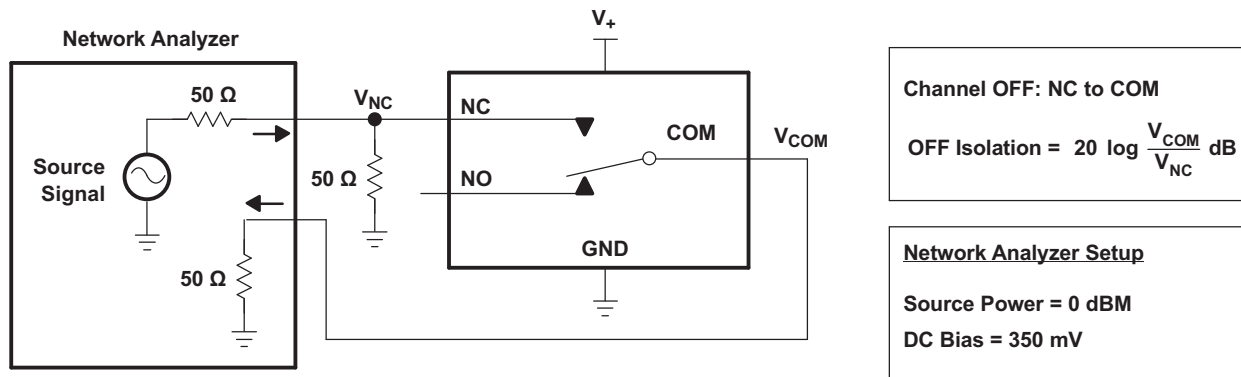


Figure 15. OFF Isolation (O_{ISO})

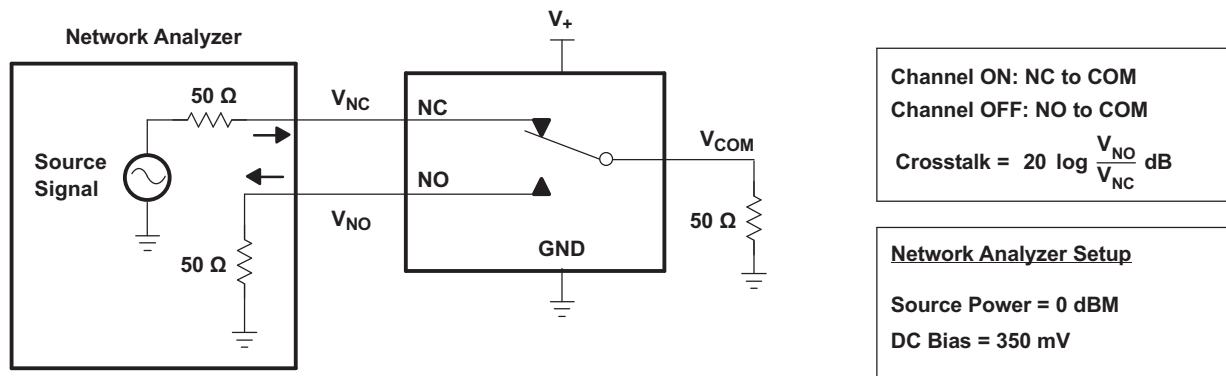


Figure 16. Crosstalk (X_{TALK})

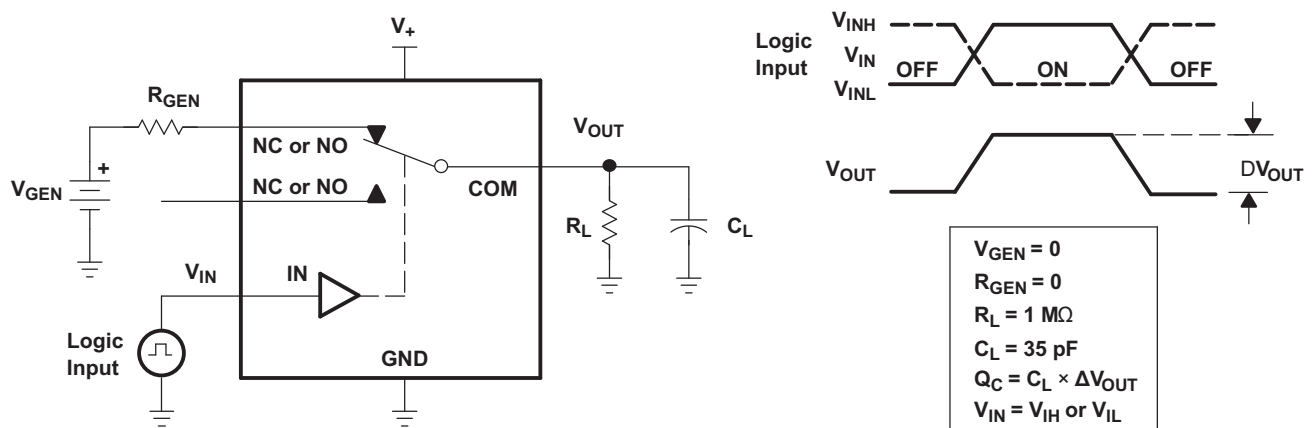


Figure 17. Charge Injection (Q_C)

Parameter Measurement Information (continued)

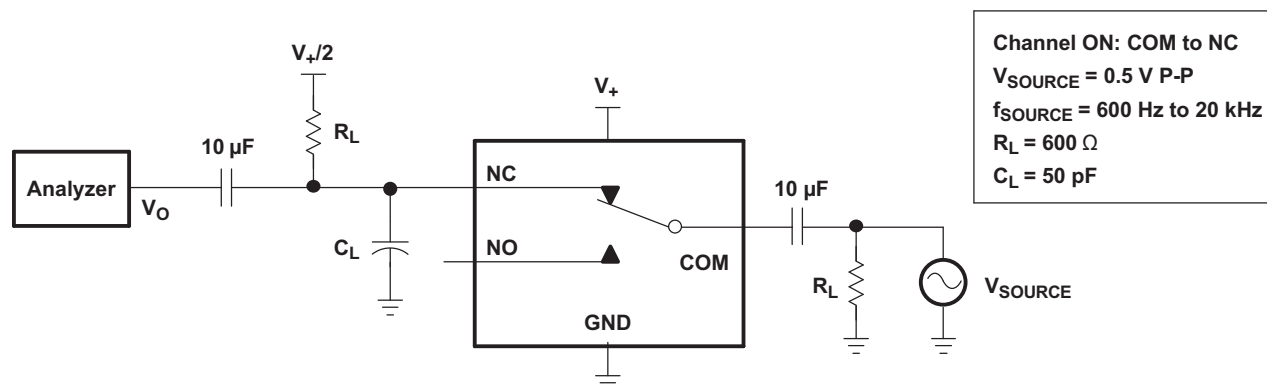


Figure 18. Total Harmonic Distortion (THD)

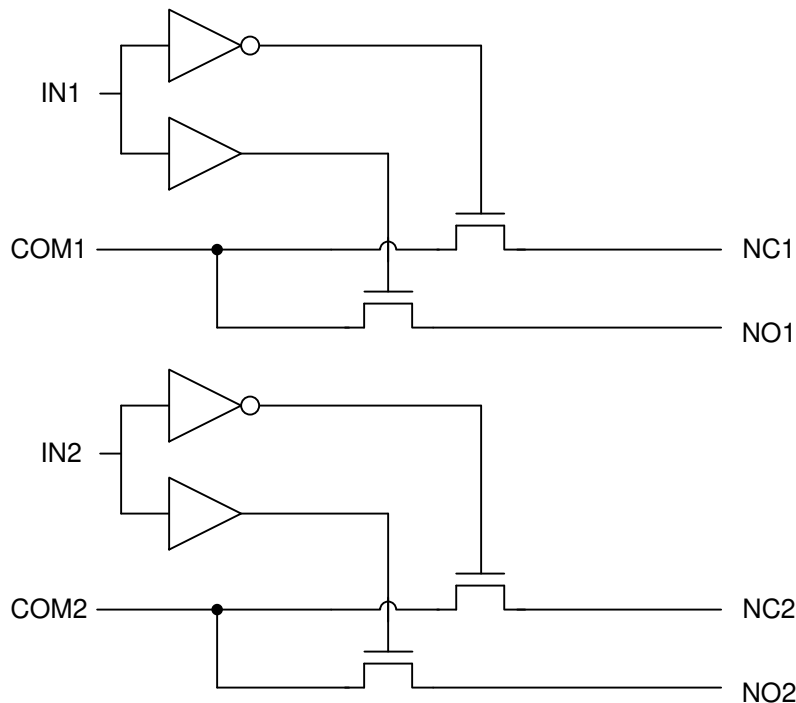
8 Detailed Description

8.1 Overview

The TS5A23157 is a dual single-pole-double-throw (SPDT) solid-state analog switch. The TS5A23157, like all analog switches, is bidirectional. When powered on, each COM pin is connected to its respective NC pin when the IN pin is low. For this device, NC stands for *normally closed* and NO stands for *normally open*. If IN is low, COM is connected to NC. If IN is high, COM is connected to NO.

The TS5A23157 is a break-before-make switch. This means that during switching, a connection is broken before a new connection is established. The NC and NO pins are never connected to each other.

8.2 Functional Block Diagram



8.3 Feature Description

The low ON-state resistance, ON-state resistance matching, and charge injection in the TS5A23157 make this switch an excellent choice for analog signals that require minimal distortion. In addition, the low THD allows audio signals to be preserved more clearly as they pass through the device.

The 1.65-V to 5.5-V operation allows compatibility with more logic levels, and the bidirectional I/Os can pass analog signals from 0 V to V_+ with low distortion. The control inputs are 5-V tolerant, allowing control signals to be present without V_{CC} .

8.4 Device Functional Modes

Table 1 lists the functional modes for TS5A23157.

Table 1. Function Table

IN	NC TO COM, COM TO NC	NO TO COM, COM TO NO
L	ON	OFF
H	OFF	ON

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TS5A3157 can be used in a variety of customer systems. The TS5A3157 can be used anywhere multiple analog or digital signals must be selected to pass across a single line.

9.2 Typical Application

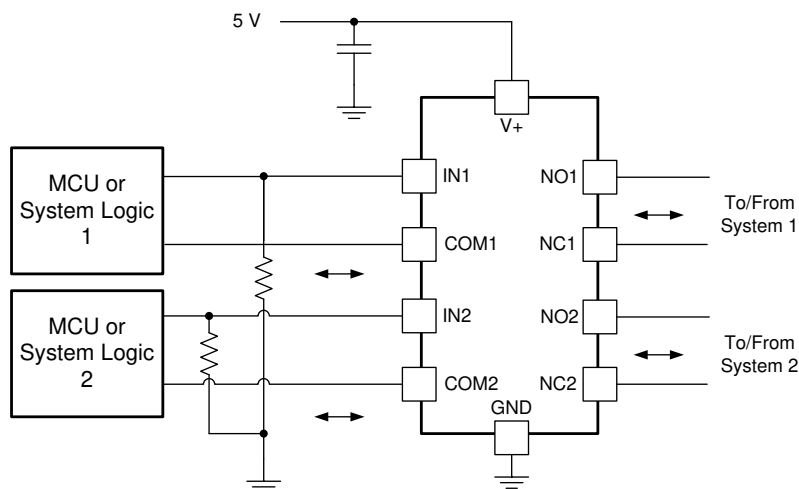


Figure 19. System Schematic for TS5A23157

9.2.1 Design Requirements

In this particular application, V_+ was 5 V, although V_+ is allowed to be any voltage specified in [Recommended Operating Conditions](#). A decoupling capacitor is recommended on the V_+ pin. See [Power Supply Recommendations](#) for more details.

9.2.2 Detailed Design Procedure

In this application, IN is, by default, pulled low to GND. Choose the resistor size based on the current driving strength of the GPIO, the desired power consumption, and the switching frequency (if applicable). If the GPIO is open-drain, use pullup resistors instead.

Typical Application (continued)

9.2.3 Application Curve

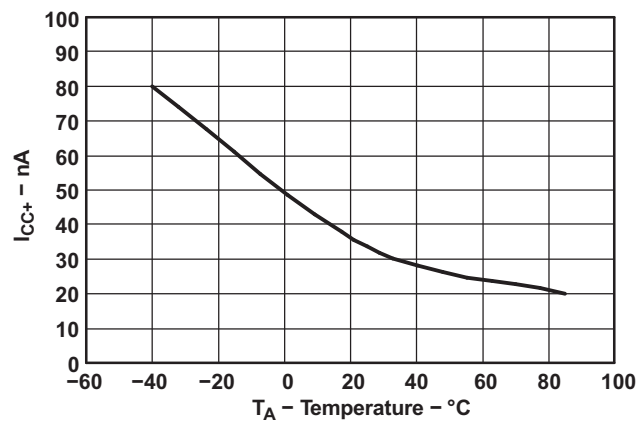


Figure 20. Power-Supply Current vs Temperature ($V_+ = 5$ V)

10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the [Recommended Operating Conditions](#).

Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1- μ F bypass capacitor is recommended. If there are multiple pins labeled V_{CC} , then a 0.01- μ F or 0.022- μ F capacitor is recommended for each V_{CC} because the V_{CC} pins will be tied together internally. For devices with dual supply pins operating at different voltages, for example V_{CC} and V_{DD} , a 0.1- μ F bypass capacitor is recommended for each supply pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

11 Layout

11.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a 90° angle, a reflection can occur. This is primarily due to the change of width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This upsets the transmission line characteristics, especially the distributed capacitance and self-inductance of the trace — resulting in the reflection. It is a given that not all PCB traces can be straight, and so they will have to turn corners. Below figure shows progressively better techniques of rounding corners. Only the last example maintains constant trace width and minimizes reflections.

Unused switch I/Os, such as NO, NC, and COM, can be left floating or tied to GND. However, the IN pin must be driven high or low. Due to partial transistor turnon when control inputs are at threshold levels, floating control inputs can cause increased I_{CC} or unknown switch selection states.

11.2 Layout Example

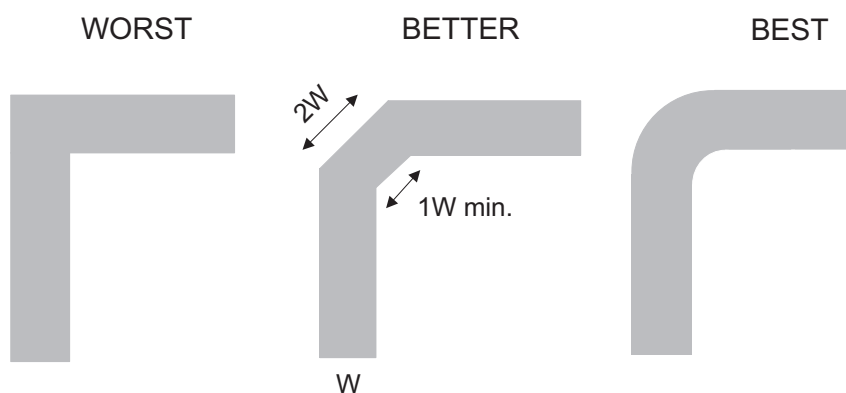


Figure 21. Trace Example

12 Device and Documentation Support

12.1 Device Support

12.1.1 Device Nomenclature

Table 2. Parameter Description

SYMBOL	DESCRIPTION
V_{COM}	Voltage at COM
V_{NC}	Voltage at NC
V_{NO}	Voltage at NO
r_{on}	Resistance between COM and NC or COM and NO ports when the channel is ON
Δr_{on}	Difference of r_{on} between channels
$r_{on(Flat)}$	Difference between the maximum and minimum value of r_{on} in a channel over the specified range of conditions
$I_{NC(OFF)}$	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the OFF state under worst-case input and output conditions
$I_{NO(OFF)}$	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the OFF state under worst-case input and output conditions
$I_{NC(ON)}$	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the ON state and the output (COM) being open
$I_{NO(ON)}$	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the ON state and the output (COM) being open
$I_{COM(ON)}$	Leakage current measured at the COM port, with the corresponding channel (NO to COM or NC to COM) in the ON state and the output (NC or NO) being open
V_{IH}	Minimum input voltage for logic high for the control input (IN)
V_{IL}	Minimum input voltage for logic low for the control input (IN)
V_{IN}	Voltage at IN
I_{IH}, I_{IL}	Leakage current measured at IN
t_{ON}	Turnon time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog outputs (COM/NC/NO) signal when the switch is turning ON.
t_{OFF}	Turnoff time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog outputs (COM/NC/NO) signal when the switch is turning OFF.
t_{BBM}	Break-before-make time. This parameter is measured under the specified range of conditions and by the propagation delay between the output of two adjacent analog channels (NC and NO) when the control signal changes state.
Q_C	Charge injection is a measurement of unwanted signal coupling from the control (IN) input to the analog (NC, NO, or COM) output. This is measured in coulombs (C) and measured by the total charge induced due to switching of the control input. Charge injection, $Q_C = C_L \times \Delta V_O$, C_L is the load capacitance and ΔV_O is the change in analog output voltage.
$C_{NC(OFF)}$	Capacitance at the NC port when the corresponding channel (NC to COM) is OFF
$C_{NO(OFF)}$	Capacitance at the NO port when the corresponding channel (NC to COM) is OFF
$C_{NC(ON)}$	Capacitance at the NC port when the corresponding channel (NC to COM) is ON
$C_{NO(ON)}$	Capacitance at the NO port when the corresponding channel (NC to COM) is ON
$C_{COM(ON)}$	Capacitance at the COM port when the corresponding channel (COM to NC or COM to NO) is ON
C_{IN}	Capacitance of IN
O_{ISO}	OFF isolation of the switch is a measurement of OFF-state switch impedance. This is measured in dB in a specific frequency, with the corresponding channel (NC to COM or NO to COM) in the OFF state. OFF isolation, $O_{ISO} = 20 \log (V_{NC}/V_{COM})$ dB, V_{COM} is the input and V_{NC} is the output.
X_{TALK}	Crosstalk is a measurement of unwanted signal coupling from an ON channel to an OFF channel (NC to NO or NO to NC). This is measured at a specific frequency and in dB. Crosstalk, $X_{TALK} = 20 \log (V_{NC1}/V_{NO1})$, V_{NO1} is the input and V_{NC1} is the output.
BW	Bandwidth of the switch. This is the frequency where the gain of an ON channel is –3 dB below the dc gain. Gain is measured from the equation, $20 \log (V_{NC}/V_{COM})$ dB, where V_{NC} is the output and V_{COM} is the input.
I_+	Static power-supply current with the control (IN) pin at V_+ or GND
ΔI_+	This is the increase in I_+ for each control (IN) input that is at the specified voltage, rather than at V_+ or GND.

Table 3. Summary of Characteristics

CONFIGURATION	2:1 MULTIPLEXER/DEMUTIPLEXER (2 × SPDT)
Number of channels	2
ON-state resistance (r_{on})	10 Ω
ON-state resistance match between channels (Δr_{on})	0.15 Ω
ON-state resistance flatness ($r_{on(flat)}$)	4 Ω
Turnon/turnoff time (t_{ON}/t_{OFF})	5.7 ns/3.8 ns
Break-before-make time (t_{BBM})	0.5 ns
Charge injection (Q_C)	7 pC
Bandwidth (BW)	220 MHz
OFF isolation (O_{SIO})	–65 dB at 10 MHz
Crosstalk 9XTALK)	–66 dB at 10 MHz
Total harmonic distortion (THD)	0.01%
Leakage current ($I_{COM(OFF)}/I_{NC(OFF)}$)	$\pm 1 \mu A$
Package options	10-pin DGS and RSE

12.2 Documentation Support

12.2.1 Related Documentation

For related documentation, see the following:

- *Implications of Slow or Floating CMOS Inputs*, [SCBA004](#)

12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](#), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TS5A23157DGSR	Active	Production	VSSOP (DGS) 10	2500 LARGE T&R	Yes	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	(3BR, JBR)
TS5A23157DGSR.B	Active	Production	VSSOP (DGS) 10	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	(3BR, JBR)
TS5A23157DGSRG4	Active	Production	VSSOP (DGS) 10	2500 null	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	JBR
TS5A23157DGSRG4.B	Active	Production	VSSOP (DGS) 10	2500 null	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	JBR
TS5A23157RSER	Active	Production	UQFN (RSE) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	JBO
TS5A23157RSER.B	Active	Production	UQFN (RSE) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	JBO
TS5A23157RSERG4.B	Active	Production	UQFN (RSE) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	JBO

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

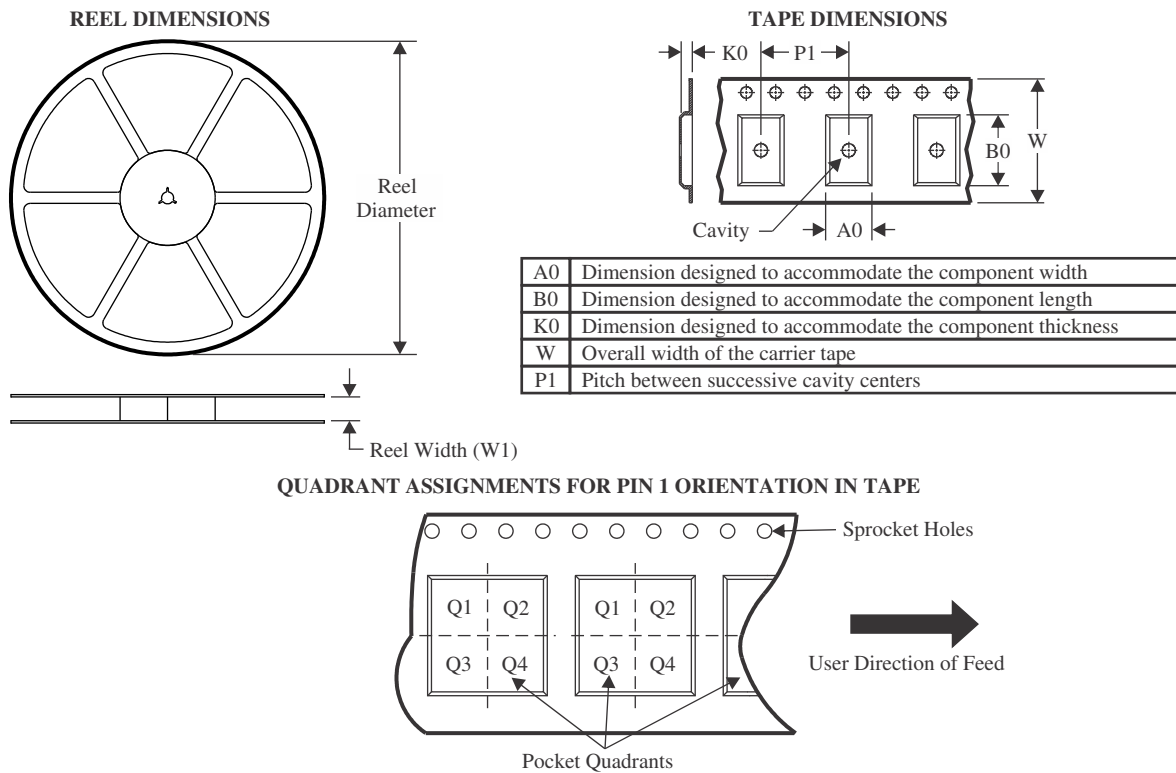
OTHER QUALIFIED VERSIONS OF TS5A23157 :

- Automotive : [TS5A23157-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

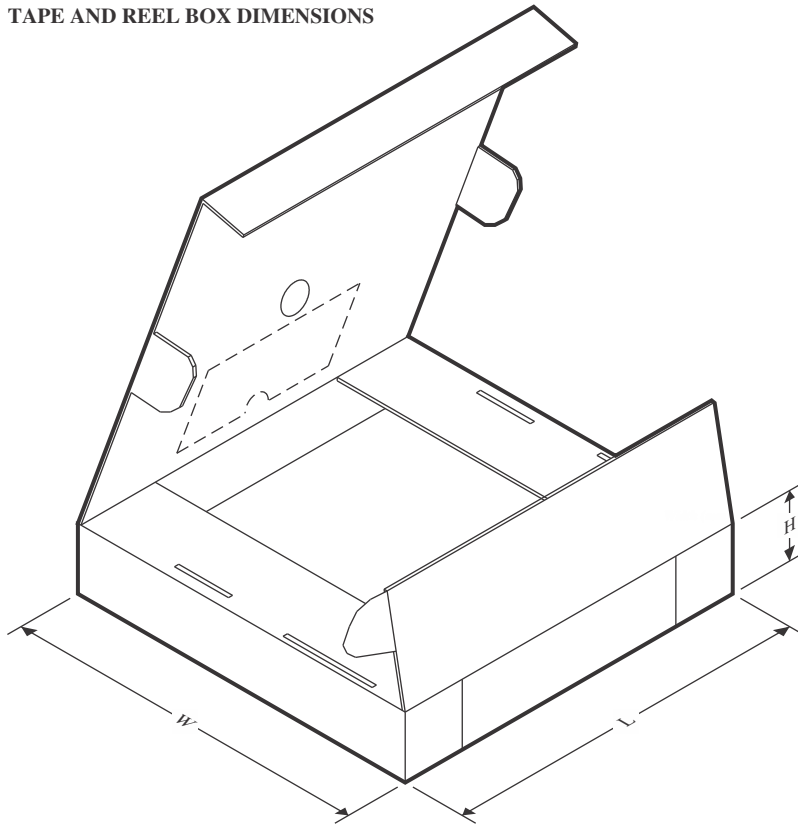
TAPE AND REEL INFORMATION



*All dimensions are nominal

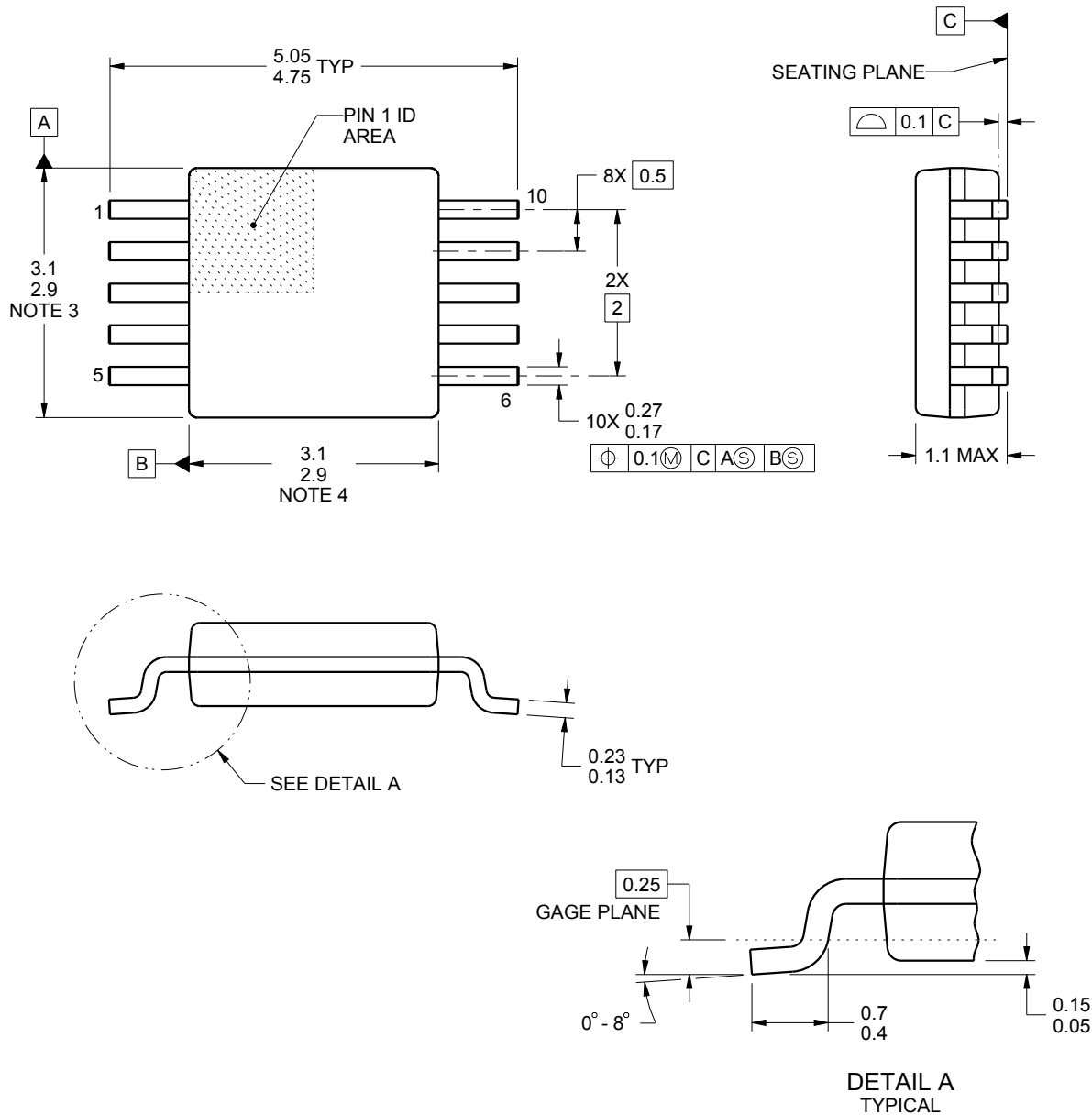
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS5A23157DGSR	VSSOP	DGS	10	2500	330.0	12.4	5.25	3.35	1.25	8.0	12.0	Q1
TS5A23157RSER	UQFN	RSE	10	3000	180.0	9.5	1.7	2.2	0.75	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS5A23157DGSR	VSSOP	DGS	10	2500	366.0	364.0	50.0
TS5A23157RSER	UQFN	RSE	10	3000	189.0	185.0	36.0



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NOTES:

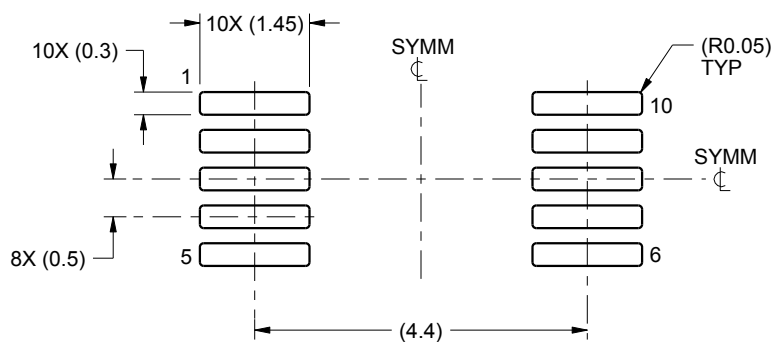
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187, variation BA.

EXAMPLE BOARD LAYOUT

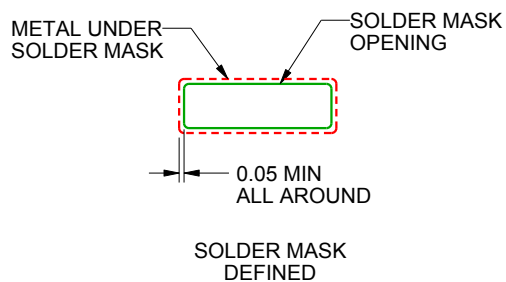
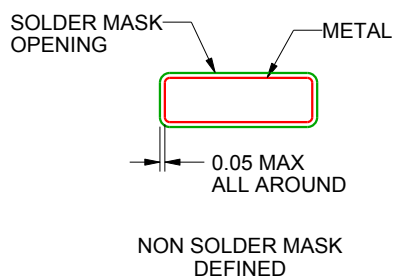
DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
SCALE:10X



SOLDER MASK DETAILS
NOT TO SCALE

4221984/A 05/2015

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

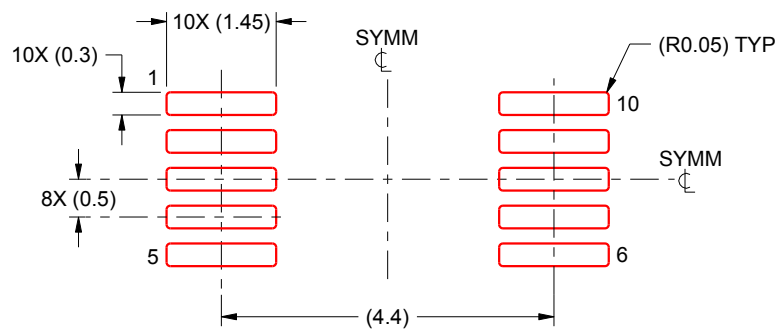
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:10X

4221984/A 05/2015

NOTES: (continued)

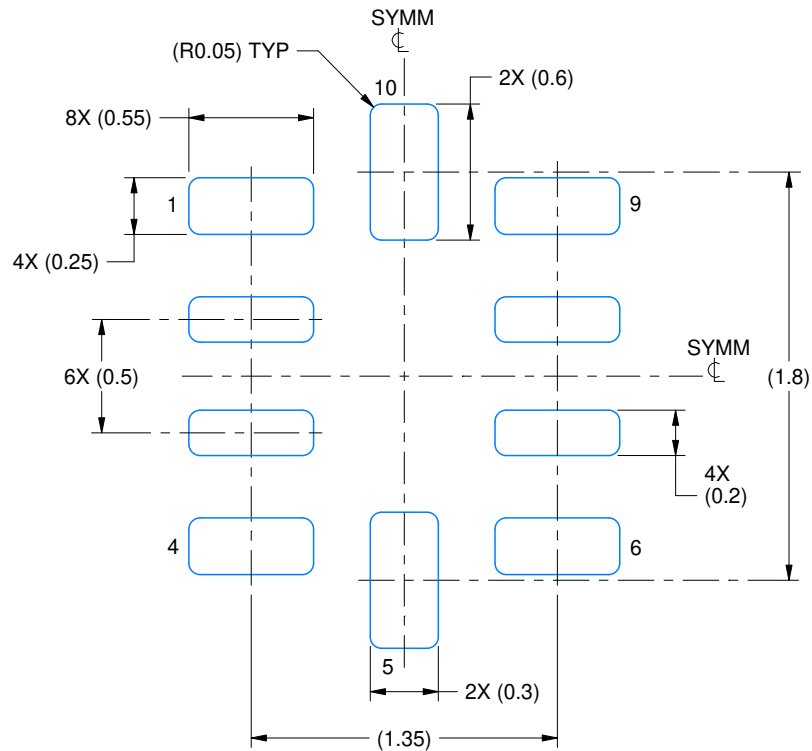
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

EXAMPLE BOARD LAYOUT

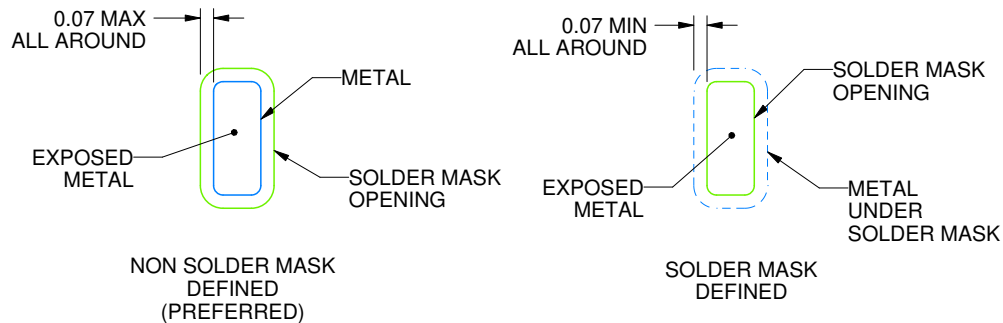
RSE0010A

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:30X



SOLDER MASK DETAILS
NOT TO SCALE

4220307/A 03/2020

NOTES: (continued)

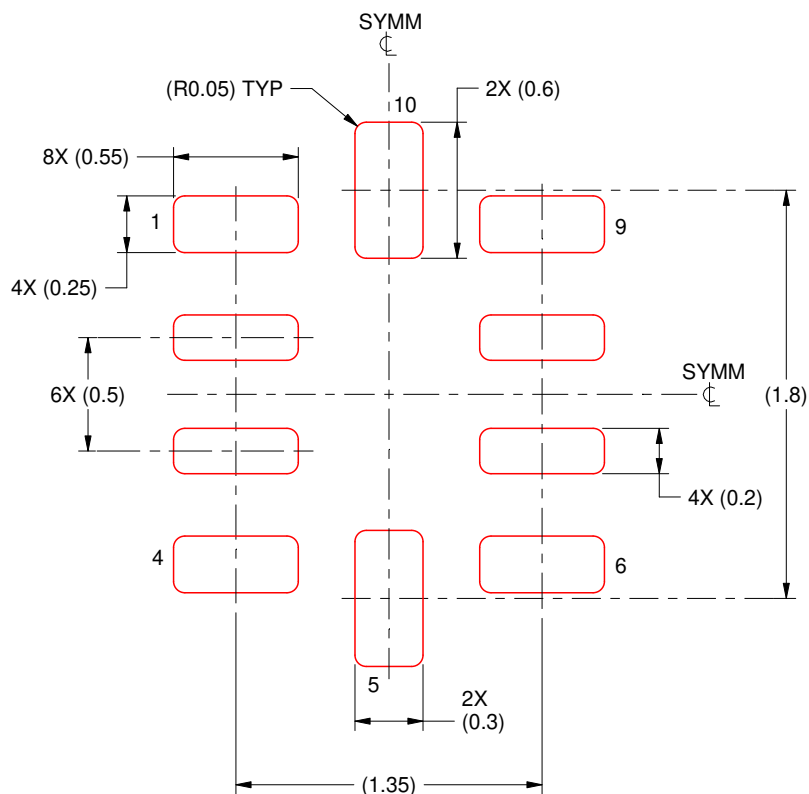
3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

EXAMPLE STENCIL DESIGN

RSE0010A

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICKNESS
SCALE: 30X

4220307/A 03/2020

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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